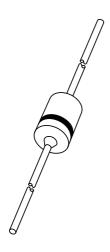
## **DISCRETE SEMICONDUCTORS**

# DATA SHEET



## BAX12; BAX12A Controlled avalanche diodes

Product specification Supersedes data of 1996 Sep 17 2002 Apr 08





## Controlled avalanche diodes

## BAX12; BAX12A

#### **FEATURES**

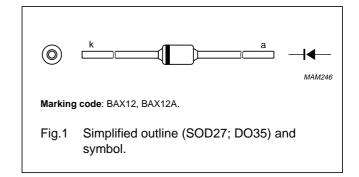
- Hermetically sealed leaded glass SOD27 (DO-35) package
- Switching speed: max. 50 ns
- · General application
- Continuous reverse voltage: max. 90 V
- Repetitive peak reverse voltage: max. 90 V
- · Repetitive peak forward current: max. 800 mA
- Repetitive peak reverse current: max. 600 mA
- · Capable of absorbing transients repetitively.

#### **APPLICATIONS**

Switching of inductive loads in semi-electronic telephone exchanges.

#### **DESCRIPTION**

The BAX12 and BAX12A are controlled avalanche diodes, fabricated in planar technology and encapsulated in the hermetically sealed leaded glass SOD27 (DO-35) package.



#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>RRM</sub>	repetitive peak reverse voltage	note 1	_	90	V
V <sub>R</sub>	continuous reverse voltage	note 1	_	90	V
I <sub>F</sub>	continuous forward current	see Fig.2; note 2	_	400	mA
I <sub>FRM</sub>	repetitive peak forward current		_	800	mA
I <sub>FSM</sub>	non-repetitive peak forward current	square wave; T <sub>j</sub> = 25 °C prior to surge; see Fig.4			
		t = 1 μs	_	55	A
		t = 100 μs	_	15	A
		t = 10 ms	_	9	A
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C; note 2	_	450	mW
I <sub>RRM</sub>	repetitive peak reverse current		_	600	mA
E <sub>RRM</sub>	repetitive peak reverse energy	$t_p \ge 50 \ \mu s; f \le 20 \ Hz; T_j = 25 \ ^{\circ}C$	_	5	mJ
T <sub>stg</sub>	storage temperature		-65	+200	°C
Tj	junction temperature		_	200	°C

### Notes

- 1. It is allowed to exceed this value; see Figs 8 and 9. Care should be taken not to exceed the I<sub>RRM</sub> rating.
- 2. Device mounted on an FR4 printed circuit-board; lead length 10 mm.

## Controlled avalanche diodes

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## **ELECTRICAL CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>F</sub>	forward voltage	see Fig.3			
		I <sub>F</sub> = 10 mA	_	750	mV
		$I_F = 50 \text{ mA}$	_	840	mV
		I <sub>F</sub> = 100 mA	_	900	mV
		I <sub>F</sub> = 200 mA	_	1	V
		$I_F = 400 \text{ mA}$	_	1.25	V
I <sub>R</sub>	reverse current	see Fig.5			
		V <sub>R</sub> = 90 V	_	100	nA
		$V_R = 90 \text{ V}; T_j = 150 ^{\circ}\text{C}$	_	100	μΑ
V <sub>(BR)R</sub>	reverse avalanche breakdown voltage				
	BAX12	$I_R = 1 \text{ mA}$	120	170	V
	BAX12A	$I_R = 0.1 \text{ mA}$	120	170	V
C <sub>d</sub>	diode capacitance	f = 1 MHz; V <sub>R</sub> = 0; see Fig.6	_	35	pF
t <sub>rr</sub>	reverse recovery time	when switched from $I_F = 30$ mA to $I_R = 30$ mA; $R_L = 100$ $\Omega$ ; measured at $I_R = 3$ mA; see Fig.10	_	50	ns

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-tp</sub>	thermal resistance from junction to tie-point	lead length 10 mm	240	K/W
R <sub>th j-a</sub>	thermal resistance from junction to ambient	lead length 10 mm; note 1	375	K/W

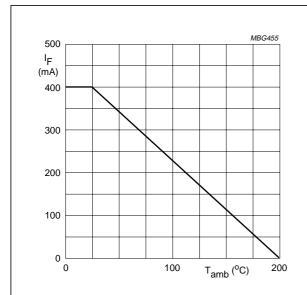
## Note

1. Device mounted on a printed circuit-board without metallization pad.

## Controlled avalanche diodes

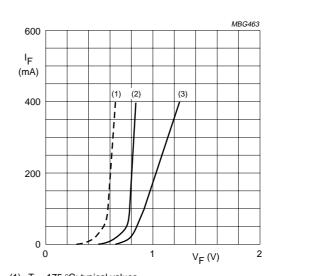
## BAX12; BAX12A

#### **GRAPHICAL DATA**



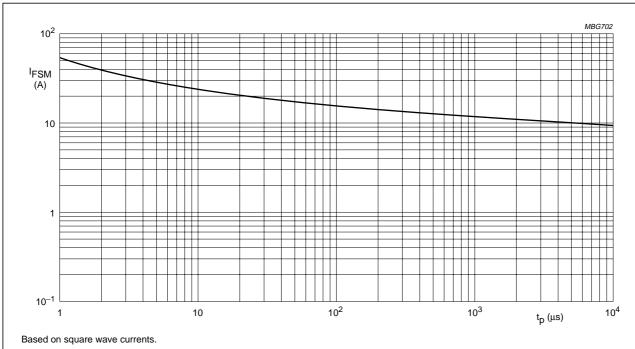
Device mounted on an FR4 printed-circuit board; lead length 10 mm.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



- (1)  $T_j = 175$  °C; typical values.
- (2) T<sub>i</sub> = 25 °C; typical values.
- (3) T<sub>i</sub> = 25 °C; maximum values.

Forward current as a function of forward voltage.



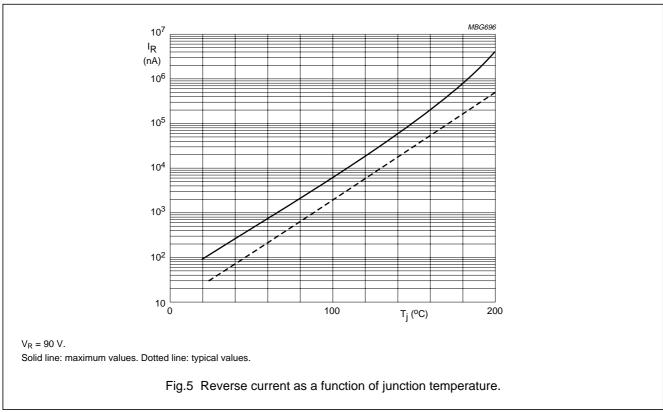
 $T_j = 25$  °C prior to surge.

Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

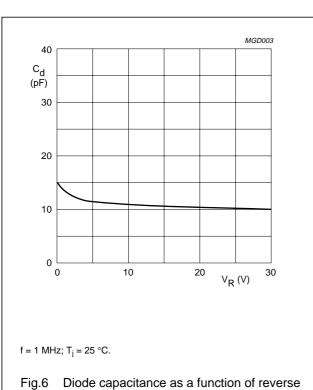
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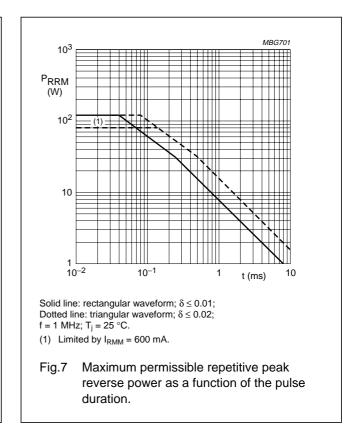
## Controlled avalanche diodes

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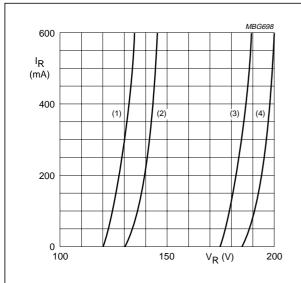


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voltage; typical values.

## Controlled avalanche diodes

## BAX12; BAX12A



Reverse voltages higher than the V<sub>R</sub> ratings are allowed, provided:

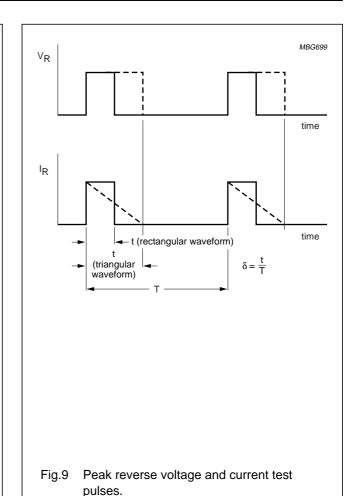
(a) The transient energy  $\leq$  7.5 mJ at  $P_{RRM} \leq$  30 W or the transient energy  $\leq$  5 mJ at  $P_{RRM} =$  120 W (T $_{\! j} =$  25 °C; see Fig.7). (b) T  $\geq$  50 ms and  $\delta \leq$  0.01 for a rectangular waveform or T  $\geq$  50 ms

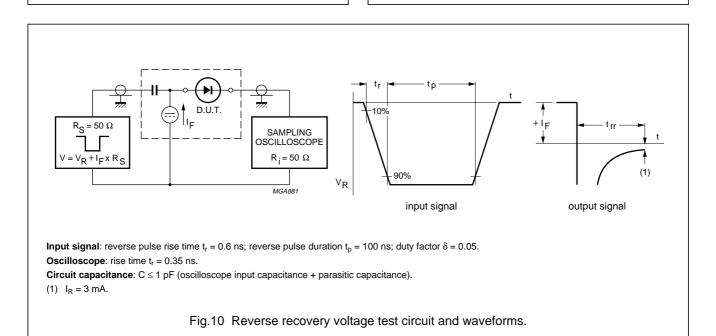
and  $\delta \leq 0.02$  for a triangular waveform (see Fig.9).

With increasing temperature, the maximum permissible transient energy must be decreased by  $0.03\ \text{mJ/K}.$ 

- (1)  $T_j = 25 \,^{\circ}\text{C}$ ; minimum values.
- (2)  $T_j = 175$  °C; minimum values.
- (3)  $T_j = 25$  °C; maximum values.
- (4)  $T_j = 175$  °C; maximum values.

Fig.8 Reverse current as a function of continuous reverse voltage.





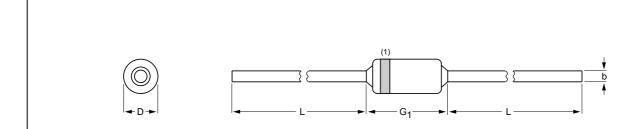
## Controlled avalanche diodes

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## **PACKAGE OUTLINE**

Hermetically sealed glass package; axial leaded; 2 leads

SOD27



#### **DIMENSIONS** (mm are the original dimensions)

UNIT	UNIT b max.		G <sub>1</sub> max.	L min.	
mm	0.56	1.85	4.25	25.4	

0 1 2 mm scale

#### Note

1. The marking band indicates the cathode.

OUTLINE	OUTLINE REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOD27	A24	DO-35	SC-40			97-06-09

## Controlled avalanche diodes

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#### **DATA SHEET STATUS**

DATA SHEET STATUS(1)	PRODUCT STATUS <sup>(2)</sup>	DEFINITIONS
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NOTES

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NOTES

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